

**Search Notes**

Application/Control No.

10/029,877

Examiner

Jia W. Lu

Applicant(s)/Patent under  
Reexamination

SIMEON ET AL.

Art Unit

2634

**SEARCHED**

Class	Subclass	Date	Examiner
375	340	3/22/2005	JL
375	526	3/22/2005	JL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
375	340	3/22/2005	JL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
US-PGPUB; USPAT; EPO;JAP;DERWENT;IBM_TDB	3/22/2005	JL
INVENTORSHIP	3/22/2005	JL